

<b>Notice of References Cited</b>	Application/Control No. 10/772,026	Applicant(s)/Patent Under Reexamination RISAN ET AL.	
	Examiner SHIN-HON CHEN	Art Unit 2131	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,950,941	09-2005	Lee et al.	713/193
*	C	US-6,993,509	01-2006	Vidich et al.	705/51
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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